

# AOT66613L/AOB66613L

60V N-Channel AlphaSGT™

# **General Description**

- Trench Power AlphaSGT<sup>™</sup> technology
- Low R<sub>DS(ON)</sub>
- Excellent Gate Charge x R<sub>DS(ON)</sub> Product (FOM)
- RoHS and Halogen-Free Compliant

## **Product Summary**

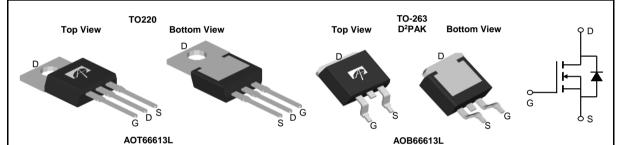
 $\begin{array}{ll} V_{DS} & 60V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 120A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 2.5 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 8V) & < 3.0 m\Omega \end{array}$ 

100% UIS Tested 100% Rg Tested



# **Applications**

- High Frequency Switching and Synchronous Rectification
- BLDC



| Orderable Part Number | Package Type | Form        | Minimum Order Quantity |
|-----------------------|--------------|-------------|------------------------|
| AOT66613L             | TO-220       | Tube        | 1000                   |
| AOB66613L             | TO-263       | Tape & Reel | 800                    |

| Parameter                              |                       | Symbol                            | Maximum    | Units |  |
|--|-----------------------|-----------------------------------|------------|-------|--|
| Drain-Source Voltage                   |                       | $V_{DS}$                          | 60         | V     |  |
| Gate-Source Voltage                    |                       | $V_{GS}$                          | ±20        | V     |  |
| Continuous Drain                       | T <sub>C</sub> =25°C  |                                   | 120        |       |  |
| Current <sup>G</sup>                   | T <sub>C</sub> =100°C | I <sub>D</sub>                    | 120        | А     |  |
| Pulsed Drain Current <sup>C</sup>      |                       | I <sub>DM</sub>                   | 480        |       |  |
| Continuous Drain<br>Current            | T <sub>A</sub> =25°C  |                                   | 44.5       | A     |  |
|  | T <sub>A</sub> =70°C  | IDSM                              | 35.5       |       |  |
| Avalanche Current C                    |                       | I <sub>AS</sub>                   | 48         | А     |  |
| Avalanche energy                       | L=0.3mH               | E <sub>AS</sub>                   | 346        | mJ    |  |
| D D'                                   | T <sub>C</sub> =25°C  | Р                                 | 260        | W     |  |
| Power Dissipation <sup>B</sup>         | T <sub>C</sub> =100°C | P <sub>D</sub>                    | 104        | VV    |  |
| Power Dissipation <sup>A</sup>         | T <sub>A</sub> =25°C  | В                                 | 8.3        | W     |  |
|  | T <sub>A</sub> =70°C  | P <sub>DSM</sub>                  | 5.3        | VV    |  |
| Junction and Storage Temperature Range |                       | T <sub>J</sub> , T <sub>STG</sub> | -55 to 150 | °C    |  |

| Thermal Characteristics        |              |                 |     |      |       |  |
|--------------------------------|--------------|-----------------|-----|------|-------|--|
| Parameter                      |              | Symbol          | Тур | Max  | Units |  |
| Maximum Junction-to-Ambient A  | t ≤ 10s      | P               | 12  | 15   | °C/W  |  |
| Maximum Junction-to-Ambient AD | Steady-State | $R_{\theta JA}$ | 50  | 60   | °C/W  |  |
| Maximum Junction-to-Case       | Steady-State | $R_{\theta JC}$ | 0.4 | 0.48 | °C/W  |  |



#### Electrical Characteristics (T<sub>.1</sub>=25°C unless otherwise noted)

| Symbol                      | Parameter                          | Conditions  |                      | Min | Тур  | Max  | Units |  |
|-----------------------------|------------------------------------|---|----------------------|-----|------|------|-------|--|
| STATIC F                    | PARAMETERS                         |   |                      |     |      |      |       |  |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage     | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V                                |                      | 60  |      |      | V     |  |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current    | V <sub>DS</sub> =60V, V <sub>GS</sub> =0V                                 |                      |     |      | 1    |       |  |
| DSS                         |                                    |   | T <sub>J</sub> =55°C |     |      | 5    | μA    |  |
| $I_{GSS}$                   | Gate-Body leakage current          | $V_{DS}$ =0V, $V_{GS}$ =±20V  |                      |     |      | ±100 | nA    |  |
| $V_{GS(th)}$                | Gate Threshold Voltage             | $V_{DS}=V_{GS}$ , $I_{D}=250\mu A$  |                      | 2.3 | 2.85 | 3.5  | V     |  |
|                             | Static Drain-Source On-Resistance  | V <sub>GS</sub> =10V, I <sub>D</sub> =20A                                 |                      |     | 2.0  | 2.5  | mΩ    |  |
| $R_{DS(ON)}$                |                                    | T <sub>J</sub> =125°C   |                      |     | 3.0  | 3.8  | 11122 |  |
|                             |                                    | $V_{GS}$ =8V, $I_D$ =20A  |                      |     | 2.2  | 3.0  | mΩ    |  |
| g <sub>FS</sub>             | Forward Transconductance           | $V_{DS}$ =5V, $I_D$ =20A  |                      |     | 100  |      | S     |  |
| $V_{SD}$                    | Diode Forward Voltage              | I <sub>S</sub> =1A, V <sub>GS</sub> =0V                                   |                      |     | 0.7  | 1    | V     |  |
| Is                          | Maximum Body-Diode Continuous Curr | rrent <sup>G</sup>  |                      |     |      | 120  | Α     |  |
| DYNAMIC                     | PARAMETERS                         |   |                      |     |      |      |       |  |
| C <sub>iss</sub>            | Input Capacitance                  | V <sub>GS</sub> =0V, V <sub>DS</sub> =30V, f=1MHz                         |                      |     | 5300 |      | pF    |  |
| Coss                        | Output Capacitance                 |   |                      |     | 1500 |      | pF    |  |
| C <sub>rss</sub>            | Reverse Transfer Capacitance       |   |                      |     | 50   |      | pF    |  |
| $R_g$                       | Gate resistance                    | f=1MHz  |                      | 0.4 | 0.9  | 1.4  | Ω     |  |
| SWITCHI                     | NG PARAMETERS                      |   |                      |     |      |      |       |  |
| <b>Q</b> <sub>g</sub> (10V) | Total Gate Charge                  | V <sub>GS</sub> =10V, V <sub>DS</sub> =30V, I <sub>D</sub> =20A           |                      |     | 78   | 110  | nC    |  |
| $Q_{gs}$                    | Gate Source Charge                 |   |                      |     | 20   |      | nC    |  |
| $Q_{gd}$                    | Gate Drain Charge                  |   |                      |     | 20   |      | nC    |  |
| Q <sub>oss</sub>            | Output Charge                      | $V_{GS}$ =0V, $V_{DS}$ =30V   |                      |     | 92   |      | nC    |  |
| t <sub>D(on)</sub>          | Turn-On DelayTime                  |   |                      |     | 23   |      | ns    |  |
| t <sub>r</sub>              | Turn-On Rise Time                  | $V_{GS}$ =10V, $V_{DS}$ =30V, $R_L$ =1.5 $\Omega$ , $R_{GEN}$ =3 $\Omega$ |                      |     | 21   |      | ns    |  |
| $t_{D(off)}$                | Turn-Off DelayTime                 |   |                      |     | 40   |      | ns    |  |
| t <sub>f</sub>              | Turn-Off Fall Time                 |   |                      |     | 13   |      | ns    |  |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time   | I <sub>F</sub> =20A, di/dt=500A/μs  |                      |     | 30   |      | ns    |  |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge | $I_F$ =20A, di/dt=500A/ $\mu$   | s                    |     | 135  |      | nC    |  |

A. The value of  $R_{aJA}$  is measured with the device mounted on  $1in^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A$  =25° C. The Power dissipation  $P_{DSM}$  is based on  $R_{aJA}$  t≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

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B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature  $T_{J(MAX)}$ =150° C.

D. The  $R_{\theta,JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta,JC}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

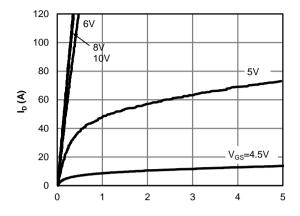
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

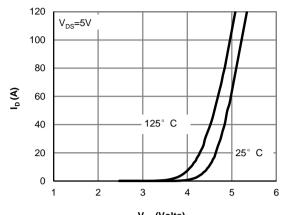
H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.



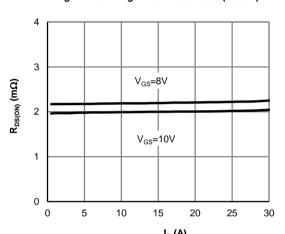
## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



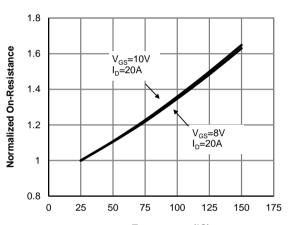
 $V_{\rm DS}$  (Volts) Figure 1: On-Region Characteristics (Note E)



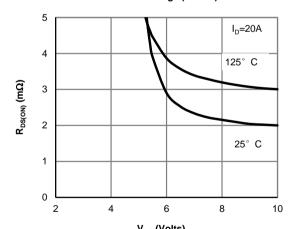
V<sub>GS</sub> (Volts) Figure 2: Transfer Characteristics (Note E)



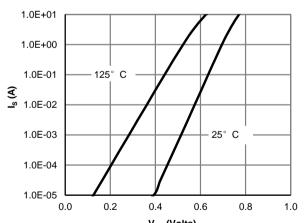
 ${\rm I_D}$  (A) Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)



Temperature (°C)
Figure 4: On-Resistance vs. Junction Temperature
(Note E)



V<sub>GS</sub> (Volts) Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)



V<sub>SD</sub> (Volts) Figure 6: Body-Diode Characteristics (Note E)

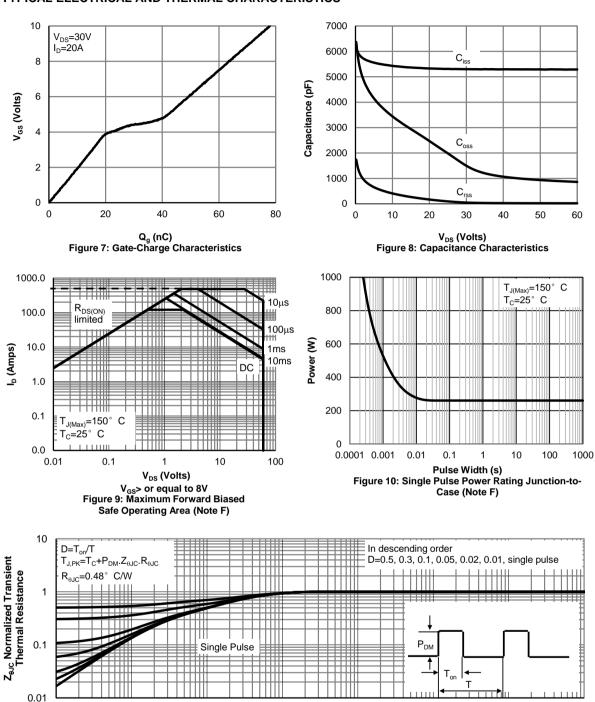


1E-05

0.0001

0.001

## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

0.01

0.1

1

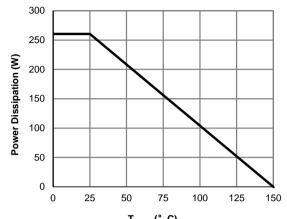
100

10

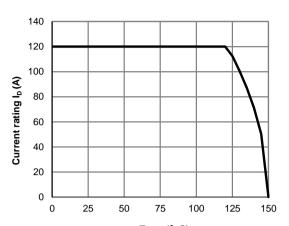
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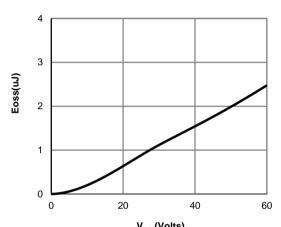
## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



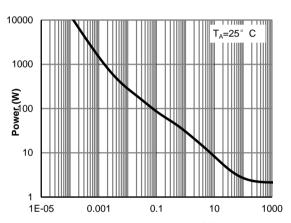
T<sub>CASE</sub> (° C) Figure 12: Power De-rating (Note F)



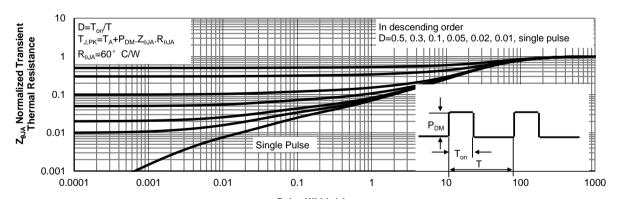
T<sub>CASE</sub> (° C)
Figure 13: Current De-rating (Note F)



V<sub>DS</sub> (Volts) Figure 14: Coss stored Energy



Pulse Width (s)
Figure 15: Single Pulse Power Rating Junctionto-Ambient (Note H)



Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

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Figure A: Gate Charge Test Circuit & Waveforms

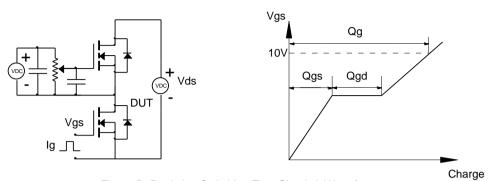


Figure B: Resistive Switching Test Circuit & Waveforms

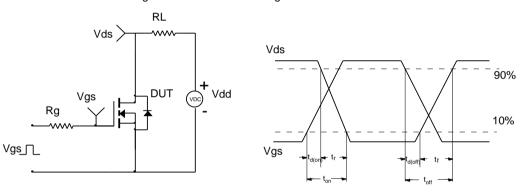


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

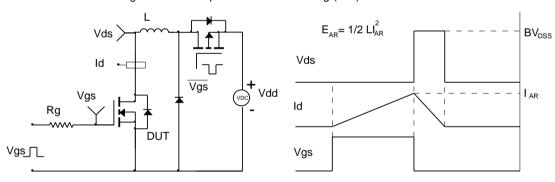
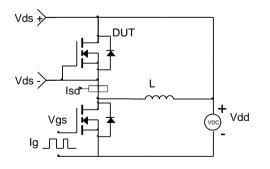
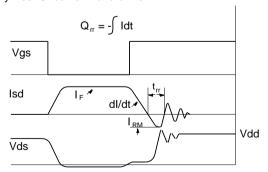


Figure D: Diode Recovery Test Circuit & Waveforms





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